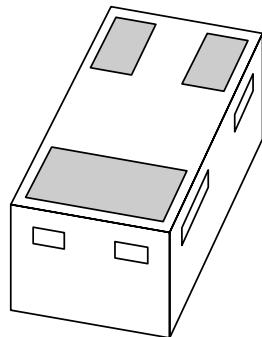


DATA SHEET



PESDxL2UM series

Low capacitance double ESD protection diode

Product specification

2003 Aug 05

Low capacitance double ESD protection diode**PESDxL2UM series****FEATURES**

- Uni-directional ESD protection of two lines or bi-directional ESD protection of one line
- Reverse standoff voltage 3.3 and 5 V
- Low diode capacitance
- Ultra low leakage current
- Leadless ultra small SOT883 surface mount package (1 × 0.6 × 0.5 mm)
- Board space 1.17 mm² (approx. 10% of SOT23)
- ESD protection >15 kV
- IEC 61000-4-2; level 4 (ESD); 15 kV (air) or 8 kV (contact).

APPLICATIONS

- Cellular handsets and accessories
- Portable electronics
- Computers and peripherals
- Communication systems
- Audio and video equipment.

MARKING

| TYPE NUMBER | MARKING CODE |
|-------------|--------------|
| PESD3V3L2UM | F2 |
| PESD5V0L2UM | F1 |

DESCRIPTION

Low capacitance ESD protection diode in a three pad SOT883 leadless ultra small plastic package designed to protect up to two transmission or data lines from ElectroStatic Discharge (ESD) damage.

PINNING

| PIN | DESCRIPTION |
|-----|--------------|
| 1 | cathode 1 |
| 2 | cathode 2 |
| 3 | common anode |

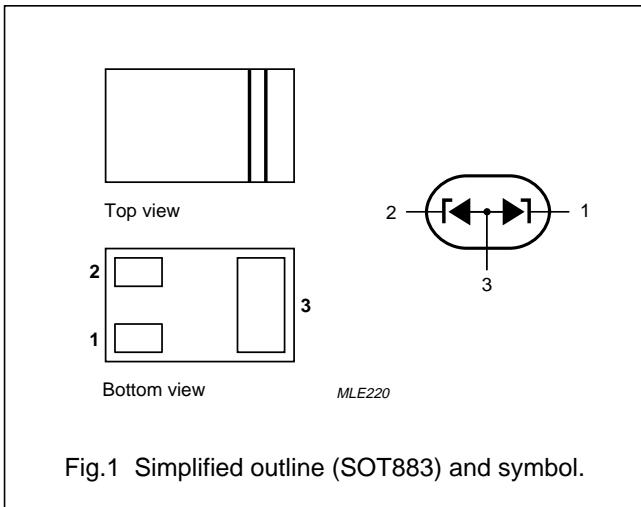


Fig.1 Simplified outline (SOT883) and symbol.

Low capacitance double ESD protection diode

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|---|---------------------------------------|------|------|------|
| Per diode | | | | | |
| I_{pp} | peak pulse current PESD3V3L2UM PESD5V0L2UM | 8/20 μ s pulse; notes 1, 2 and 3 | — | 3 | A |
| | | | — | 2.5 | A |
| P_{pp} | peak pulse power | 8/20 μ s pulse; notes 1, 2 and 3 | — | 30 | W |
| I_{FSM} | non-repetitive peak forward current | $t_p = 1$ ms; square pulse | — | 3.5 | A |
| I_{ZSM} | non-repetitive peak reverse current PESD3V3L2UM PESD5V0L2UM | $t_p = 1$ ms; square pulse | — | 0.9 | A |
| | | | — | 0.8 | A |
| P_{tot} | total power dissipation | $T_{amb} = 25$ °C; note 4 | — | 250 | mW |
| P_{ZSM} | non-repetitive peak reverse power dissipation | $t_p = 1$ ms; square pulse; see Fig.4 | — | 6 | W |
| T_{stg} | storage temperature | | -65 | +150 | °C |
| T_j | junction temperature | | — | 150 | °C |
| ESD | electrostatic discharge | IEC 61000-4-2 (contact discharge) | 15 | — | kV |
| | | HBM MIL-Std 883 | 10 | — | kV |

Notes

1. Non-repetitive current pulse 8/20 μ s exponential decay waveform; see Fig.5.
2. Pins 1 and 3 or 2 and 3.
3. Pins 1 and 2.
4. Device mounted on standard printed-circuit board.

ESD standards compliance

| | |
|------------------------------|-------------------------------|
| IEC 61000-4-2, level 4 (ESD) | >15 kV (air); >8 kV (contact) |
| HBM MIL-Std 883, class 3 | >4 kV |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---------------------------|-------|------|
| $R_{th\ j-a}$ | thermal resistance from junction to ambient | all diodes loaded; note 1 | 500 | K/W |
| | | one diode loaded; note 2 | 290 | K/W |

Notes

1. Refer to SOT883 standard mounting conditions (footprint), FR4 with 60 μ m copper strip line.
2. FR4 single-sided copper 1 cm^2 .

Low capacitance double ESD protection diode

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ELECTRICAL CHARACTERISTICS

T_i = 25 °C unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------|---------------------------|--|------|------|------|----------|
| Per diode | | | | | | |
| V_F | forward voltage | $I_F = 200 \text{ mA}$ | – | 1 | 1.2 | V |
| V_{RWM} | reverse stand-off voltage | | – | – | 3.3 | V |
| | PESD3V3L2UM | | – | – | 5 | V |
| I_{RM} | reverse leakage current | | | | | |
| | PESD3V3L2UM | $V_R = 3.3 \text{ V}$ | – | 75 | 300 | nA |
| | PESD5V0L2UM | $V_R = 5 \text{ V}$ | – | 5 | 25 | nA |
| $V_{(CL)R}$ | clamping voltage | 8/20 μs pulse | | | | |
| | PESD3V3L2UM | $I_{pp} = 1 \text{ A}$; notes 1 and 2 | – | – | 8 | V |
| | | $I_{pp} = 3 \text{ A}$; notes 1 and 2 | – | – | 12 | V |
| | | $I_{pp} = 1 \text{ A}$; notes 1 and 3 | – | – | 9 | V |
| | | $I_{pp} = 3 \text{ A}$; notes 1 and 3 | – | – | 13 | V |
| | PESD5V0L2UM | $I_{pp} = 1 \text{ A}$; notes 1 and 2 | – | – | 10 | V |
| | | $I_{pp} = 2.5 \text{ A}$; notes 1 and 2 | – | – | 13 | V |
| | | $I_{pp} = 1 \text{ A}$; notes 1 and 3 | – | – | 11 | V |
| | | $I_{pp} = 2.5 \text{ A}$; notes 1 and 3 | – | – | 15 | V |
| | | | | | | |
| V_{BR} | breakdown voltage | $I_Z = 1 \text{ mA}$ | | | | |
| | PESD3V3L2UM | | 5.32 | 5.6 | 5.88 | V |
| | PESD5V0L2UM | | 6.46 | 6.8 | 7.14 | V |
| S_Z | temperature coefficient | $I_Z = 1 \text{ mA}$ | | | | |
| | PESD3V3L2UM | | – | 1.3 | – | mV/K |
| | PESD5V0L2UM | | – | 2.9 | – | mV/K |
| r_{diff} | differential resistance | $I_R = 1 \text{ mA}$ | | | | |
| | PESD3V3L2UM | | – | – | 200 | Ω |
| | PESD5V0L2UM | | – | – | 100 | Ω |
| C_d | diode capacitance | | | | | |
| | PESD3V3L2UM | $f = 1 \text{ MHz}; V_R = 0$ | – | 22 | 28 | pF |
| | | $f = 1 \text{ MHz}; V_R = 5$ | – | 12 | 17 | pF |
| | PESD5V0L2UM | $f = 1 \text{ MHz}; V_R = 0$ | – | 16 | 19 | pF |
| | | $f = 1 \text{ MHz}; V_R = 5$ | – | 8 | 11 | pF |
| | | | | | | |

Notes

1. Non-repetitive current pulse 8/20 μ s exponential decay waveform; see Fig.5.
2. Pins 1 and 3 or 2 and 3.
3. Pins 1 and 2.

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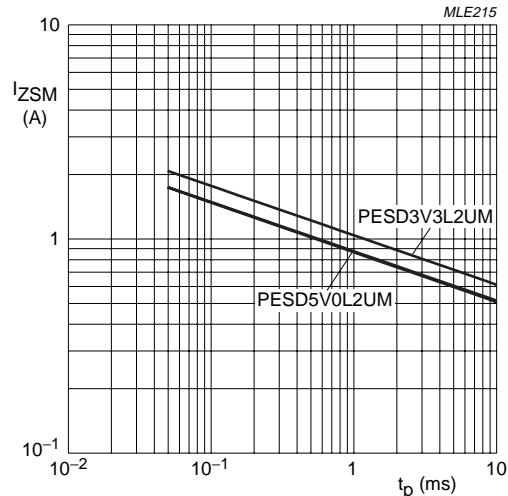
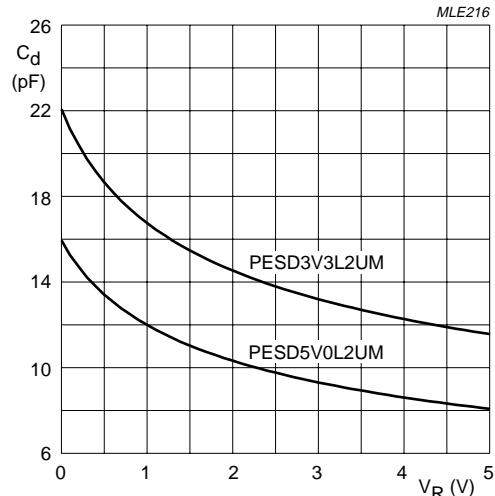
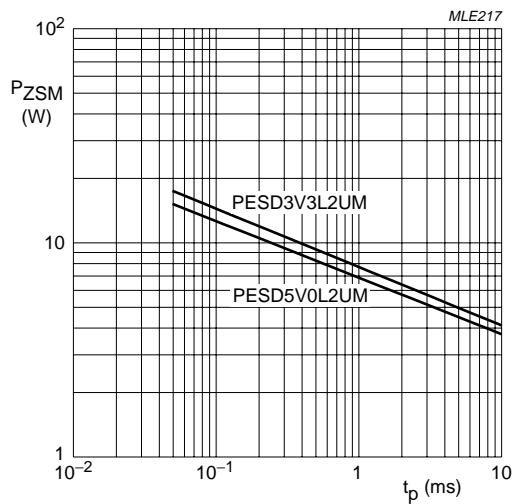


Fig.2 Non-repetitive peak reverse current as a function of pulse time (square pulse).



T_j = 25 °C; f = 1 MHz.

Fig.3 Diode capacitance as a function of reverse voltage; typical values.



P_{ZSM} = V_{ZSM} × I_{ZSM}.
V_{ZSM} is the non-repetitive peak reverse voltage at I_{ZSM}.

Fig.4 Maximum non-repetitive peak reverse power dissipation as a function of pulse duration (square pulse).

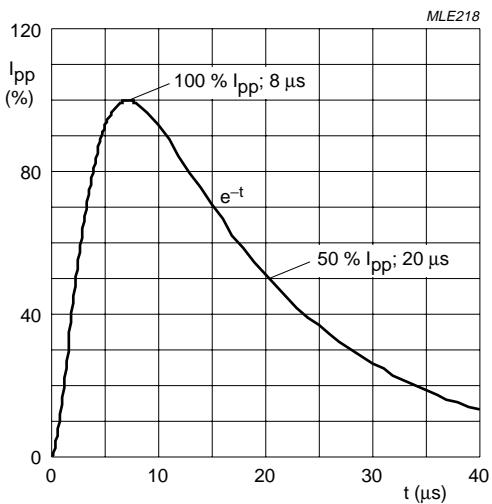


Fig.5 8/20 μs pulse waveform according to IEC 61000-4-5.

Low capacitance double ESD protection diode

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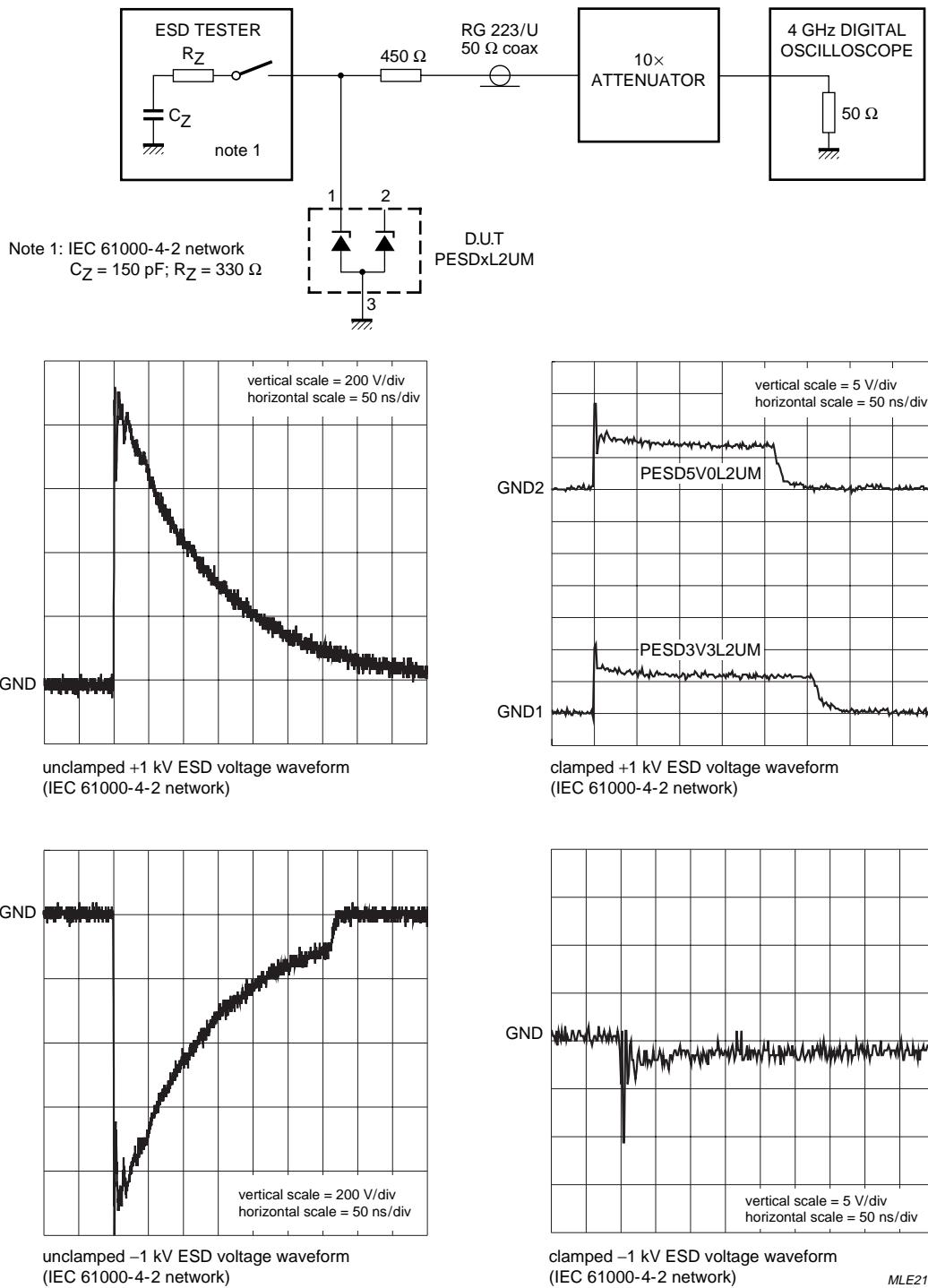


Fig.6 ESD clamping test set-up and waveforms.

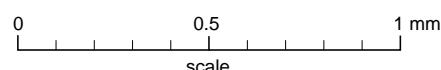
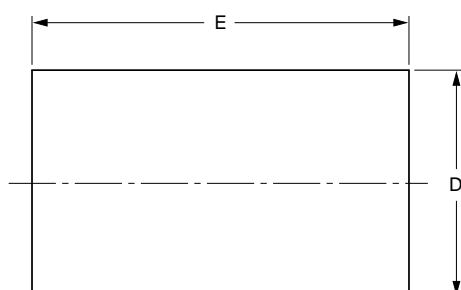
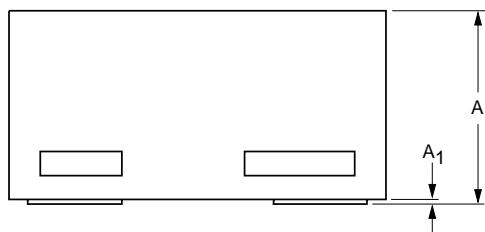
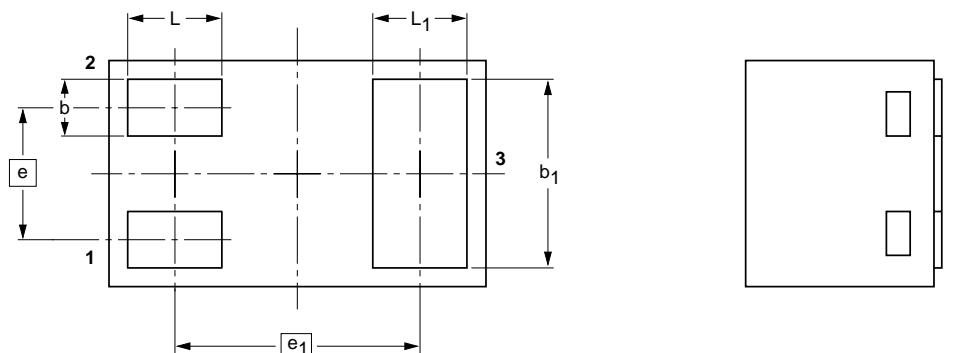
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PACKAGE OUTLINE

Leadless ultra small plastic package; 3 solder lands; body 1.0 x 0.6 x 0.5 mm

SOT883



DIMENSIONS (mm are the original dimensions)

| UNIT | A ⁽¹⁾ | A ₁ max. | b | b ₁ | D | E | e | e ₁ | L | L ₁ |
|------|------------------|------------------------|--------------|----------------|--------------|--------------|------|----------------|--------------|----------------|
| mm | 0.50 0.46 | 0.03 | 0.20 0.12 | 0.55 0.47 | 0.62 0.55 | 1.02 0.95 | 0.35 | 0.65 | 0.30 0.22 | 0.30 0.22 |

Note

1. Including plating thickness

| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|--------------------|------------|-------|-------|--------|------------------------|----------------------|
| | IEC | JEDEC | JEITA | SC-101 | | |
| SOT883 | | | | | | 03-02-05 03-04-03 |

Low capacitance double ESD protection diode

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